Diffraction

Wavenumber $k = \frac{2\pi}{2}$ $\omega = 2\pi f$ Frequency

Wave speed $c = f \lambda$ $\omega = ck$ Wave power input $P = \frac{1}{2}ZA^2\omega^2$

Z = Wave impedance

The Huygens-Fresnel Principle states: "Every unobstructed point of a wavefront, at a given instant, serves as a source of spherical secondary wavelets (with the same frequency as that of the primary wave). The amplitude of the optical field at any point beyond is the superposition of all these wavelets (considering their amplitudes and relative phases)."

Hence to determine the wavefield beyond an illuminated edge of slit, we need to add up the effect of spherical wave sources in the vicinity of the slit or aperture.

 $\cos x = \frac{1}{2} \left(e^{ix} + e^{-ix} \right)$

An infinitesimally thin slit



Two infinitesimally thin slits



Cosine Rule: $p^{2} = r^{2} + \frac{1}{4}d^{2} - rd\cos(90^{\circ} - \theta)$ $p^{2} = r^{2} + \frac{1}{4}d^{2} - rd\sin\theta$ $q^{2} = r^{2} + \frac{1}{4}d^{2} - rd\cos(90^{\circ} + \theta)$ $p^{2} = r^{2} + \frac{1}{4}d^{2} + rd\sin\theta$

$$p = r\sqrt{1 + \frac{1}{4}\frac{d^{2}}{r^{2}} - \frac{d\sin\theta}{r}}$$

$$q = r\sqrt{1 + \frac{1}{4}\frac{d^{2}}{r^{2}} + \frac{d\sin\theta}{r}}}$$

$$Q = r\sqrt{1 + \frac{1}{4}\frac{d^{2}}{r^{2}} + \frac{1}{2}d\sin\theta}$$

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lent geometry is t sources are at the ingle (i.e. plane Phase difference but separated by $\Delta \phi = -\frac{1}{2}kd\sin\theta$ This only works because $\frac{1}{2}d$ $r \gg d$ Phase difference $\frac{1}{2}d$ $\Delta \phi = \frac{1}{2} k d \sin \theta$ Youngs Double slits: $\lambda = 650$ nm, $d = 5\lambda$ -50 50 0 θo

 $\sin\theta = \cos(90^\circ - \theta)$

 $-\sin\theta = \cos(90^\circ + \theta)$

The diffraction pattern of a finite width slit

The analysis of the double slit can be extended to include pairs of infinitesimal slits which cover the whole aperture width a

> Define A/a in this case to be the illumination amplitude per unit length of the aperture

Assuming
$$r \gg a$$

$$d\psi \approx \frac{A}{a} dz \frac{e^{-i\omega t}}{r} e^{ik\left(r + \frac{1}{2}\frac{z^{2}}{r}\right)} \left(e^{-ikz\sin\theta} + e^{ikz\sin\theta}\right)$$
i.e. from Double slit analysis, but use $\frac{1}{2}d \rightarrow z$

$$\frac{\partial}{\partial t} = \int d\psi = \int_{0}^{\frac{1}{2}a} \frac{Ae^{-i\omega t}}{ar} e^{ik\left(r + \frac{1}{2}\frac{z^{2}}{r}\right)} \left(e^{-ikz\sin\theta} + e^{ikz\sin\theta}\right) dz$$

$$\Rightarrow \psi = \frac{Ae^{i(kr-\omega t)}}{ar} \int_{0}^{\frac{1}{2}a} e^{\frac{ikz^{2}}{2r}} \left(e^{-ikz\sin\theta} + e^{ikz\sin\theta}\right) dz$$

This integral can be simplified into two regimes:

 $e^{\frac{ikz^2}{2r}} \approx \text{constant}$ **Fraunhofer** – or 'linear phase' with z

$$\frac{k\left(\frac{1}{2}a\right)^{2}}{2r} \ll 1 \qquad \qquad \psi = \frac{Ae^{i(kr-\omega t)}}{ar} \int_{0}^{\frac{1}{2}a} \left(e^{-ikz\sin\theta} + e^{ikz\sin\theta}\right) dz$$

$$\frac{2\pi a^{2}}{8\lambda r} \ll 1 \qquad \qquad \psi = \frac{2Ae^{i(kr-\omega t)}}{ar} \int_{0}^{\frac{1}{2}a} \cos\left(kz\sin\theta\right) dz$$

$$r \gg \frac{\pi a^{2}}{4\lambda} \qquad \qquad \psi = \frac{2Ae^{i(kr-\omega t)}}{ar} \left[\frac{\sin\left(kz\sin\theta\right)}{k\sin\theta}\right]_{0}^{\frac{1}{2}a}$$

$$|\psi|^{2} = \frac{A^{2}}{r^{2}} \left(\frac{\sin\left(\frac{1}{2}ka\sin\theta\right)}{\frac{1}{2}ka\sin\theta}\right)^{2}$$

$$\theta = 0; \quad |\psi|^2 = |\psi_0|^2 = \frac{A^2}{r^2}$$
$$\therefore \quad \left|\frac{\psi}{\psi_0}\right|^2 = \left(\frac{\sin\left(\frac{1}{2}ka\sin\theta\right)}{\frac{1}{2}ka\sin\theta}\right)^2$$





Fraunhofer far field diffraction: $\lambda = 650$ nm, $a = 5\lambda$

 $dB(x) = 10\log_{10} x$

50

0.5

0.08

 $\lim_{x \to 0} \left(\frac{\sin x}{x} \right) = 1$

0

-5

Normalized wave power /dB 0, 10 0; 10 0; 01

-25

Generalized Fresnel wavefield

We can derive the Fresnel regime wavefield for more general geometries, and apply this to determine the diffraction pattern of a 'knife edge.'

Consider the uniformly illuminated aperture to extend from z_1 to z_2 .

Drawing not to scale! Assume $r \gg z_2 - z_1$ $z_2 \wedge$ Pythagoras' Theorem Ζ. $p = \sqrt{z^{2} + r^{2}} = r\sqrt{1 + \frac{z^{2}}{r^{2}}} \approx r\left(1 + \frac{1}{2}\frac{z^{2}}{r^{2}}\right) = r + \frac{1}{2}\frac{z^{2}}{r}$ If $r \gg z$ as well as $r \gg z_2 - z_1$ As in the previous examples, the effect of the quadratic term in z will only effect the phase significantly and not the amplitude Z_1 Ψ $\bigvee_{z_1} \psi(r,t) = \int_{z_1}^{z_2} \frac{A}{a} \frac{e^{i(kp-\omega t)}}{r} dz$ r $r \gg z$, $p \approx r + \frac{1}{2} \frac{z^2}{r}$ $\therefore \psi(r,t) \approx \frac{Ae^{i(kr-\omega t)}}{r} \int_{z_1}^{z_2} e^{\frac{ikz^2}{2r}} dz$ In this case, absorb a into constant A which could be

calculated by direct wave intensity measurement.

$$k = \frac{2\pi}{\lambda}$$

$$\psi = \frac{Ae^{i(kr-ar)}}{r} \int_{z_{1}}^{z_{2}} \frac{ixz^{2}}{\lambda r} dz \quad \text{Consider substitution} \quad \frac{1}{2}\pi t^{2} = \frac{\pi z^{2}}{\lambda r} \Rightarrow t = z\sqrt{\frac{2}{\lambda r}} \Rightarrow dz = dt\sqrt{\frac{1}{2}\lambda r}$$

$$\psi = \frac{Ae^{i(kr-ar)}}{r} \sqrt{\frac{1}{2}\lambda r} \int_{z_{1}}^{z_{1}} \frac{\sqrt{\frac{2}{2}r}}{z_{1}} (\cos(\frac{1}{2}\pi t^{2}) + i\sin(\frac{1}{2}\pi t^{2})) dt$$

$$|\psi|^{2} = \frac{A^{2}}{2r} |C(w_{2}) - C(w_{1}) + iS(w_{2}) - iS(w_{1})|^{2}$$

$$w_{1,2} = z_{1,2}\sqrt{\frac{2}{\lambda r}}$$

$$Now for a 'knife edge' z_{1} = z, \quad z_{3} = \infty$$

$$|\psi|^{2} = \frac{A^{2}\lambda}{2r} |C(\infty) - C(w) + iS(\infty) - iS(w)|^{2}$$

$$w = z\sqrt{\frac{2}{\lambda r}}$$
From the Corru Spiral one can see that
$$S(\infty) = C(\infty) = \frac{1}{2}$$

$$\therefore |\psi|^{2} = \frac{A^{2}\lambda}{2r} |\frac{1}{2}(1+i) - C(w) - iS(w)|^{2}$$
Now if we are above the knife edge by z: (rather than below) we must exchange its sign. Since w is proportional to z:
$$|\psi|^{2} = \frac{A^{2}\lambda}{\lambda r} |\frac{1}{2}(1+i) + C(w) + iS(w)|^{2}$$

$$w = z\sqrt{\frac{2}{\lambda r}} |\frac{1}{2}(1+i) + C(w) + iS(w)|^{2}$$

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$$w = z\sqrt{\frac{2}{\lambda r}} |\frac{1}{2}(1+i) + C(w) + iS(w)|^{2}}$$

 $C(\pm w) = \pm C(w)$ $S(\pm w) = \pm S(w)$

W

W

k

Ψ

Ψ

 $|\psi|$

 Z_1

 ψ

W

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Far-field (Fraunhofer) diffraction pattern of a grating



Assume 'far-field' (Fraunhofer) scenario – i.e. $r \gg z$

$$\therefore p \approx r \left(1 - \frac{z}{r} \sin \theta \right) = r - z \sin \theta \quad \text{i.e. plane waves arriving at } r, \theta$$

$$\psi(r,t) \approx \frac{Ae^{i(kr-ot)}}{Nwr} \sum_{n=1}^{N} \int_{ns-w}^{ns} e^{-ikz \sin \theta} dz$$

$$\psi(r,t) \approx \frac{Ae^{i(kr-ot)}}{Nwr} \sum_{n=1}^{N} \left[\frac{e^{-ikz \sin \theta}}{-ik \sin \theta} \right]_{ns-w}^{ns}$$

$$\psi(r,t) \approx \frac{Ae^{i(kr-ot)}}{Nwr} \sum_{n=1}^{N} \frac{1}{-ik \sin \theta} \left(e^{-ikns \sin \theta} - e^{-ik(ns-w) \sin \theta} \right)$$

$$\begin{split} \psi(r,t) &\approx \frac{Ae^{i(kr-\omega t)}}{Nwr} \sum_{n=1}^{N} \frac{1}{-ik\sin\theta} e^{-ik(ns-\frac{1}{2}w)\sin\theta} \left(e^{-ik\frac{1}{2}w\sin\theta} - e^{ik\frac{1}{2}w\sin\theta} \right) \\ \psi(r,t) &\approx \frac{Ae^{i(kr-\omega t)}}{Nr} \frac{1}{\frac{1}{2}kw\sin\theta} \frac{1}{2i} \left(e^{ik\frac{1}{2}w\sin\theta} - e^{-ik\frac{1}{2}w\sin\theta} \right) \sum_{n=1}^{N} e^{-ik(ns-\frac{1}{2}w)\sin\theta} \\ \psi(r,t) &\approx \frac{Ae^{i(kr-\omega t)}}{Nr} \frac{\sin\left(\frac{1}{2}kw\sin\theta\right)}{\frac{1}{2}kw\sin\theta} e^{-ik\frac{1}{2}w\sin\theta} \sum_{n=1}^{N} \left(e^{-iks\sin\theta} \right)^{n} \\ \psi(r,t) &\approx \frac{Ae^{i(kr-\omega t)}}{Nr} \frac{\sin\left(\frac{1}{2}kw\sin\theta\right)}{\frac{1}{2}kw\sin\theta} e^{-ik\frac{1}{2}w\sin\theta} \frac{e^{-ik\sin\theta} - e^{-ik(N+1)s\sin\theta}}{1 - e^{-iks\sin\theta}} \end{split}$$

The last step uses the formula for the sum of a geometric series

$$\sum_{n=1}^{N} ar^{n-1} = a + ar + \dots + ar^{N-1} = a \frac{1-r^{N}}{1-r} \quad \therefore \quad a \frac{1-r^{N}}{1-r} = \frac{a}{r} \sum_{n=1}^{N} r^{n} \quad \Rightarrow \sum_{n=1}^{N} r^{n} = \frac{r-r^{N+1}}{1-r}$$













where *d* is a characteristic length of the grating, slit etc. For any optical instrument, the 'resolving power' is likely to be diffraction limited. So this ratio gives the minimum angular deviation that two objects could be resolved via an optical system.

This is the actual formula for the diffraction pattern wave power. It incorporates all the maxima and minima effects described above.



e.g. for the James Web space telescope, d = 6.5m. So for Infra-Red light of wavelength 3.15μ m, $\Delta\theta$ is about 0.1 arc-seconds*.

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 $=41.8^{\circ}$

Bragg's law of X-ray diffraction from atoms in a crystal lattice



Modelling general diffraction effects from a finite width slit

We can use a computer to evaluate the wavefield in the vicinity of a finite width slit which is uniformly illuminated. We are therefore not restricted to the limitations of the Fraunhofer and Fresnel regimes



Decibels are a useful measure of power over a large range of values $dB(x) = \log_{10} x$

Sir William Henry

Bragg 1862-1942

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